TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (MACH II π -MOS V)

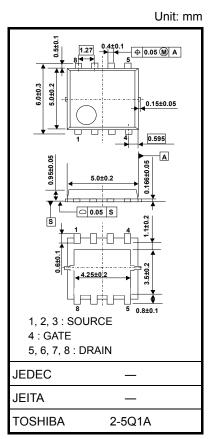
TPCA8010-H

High Speed Switching Applications Switching Regulator Applications DC/DC Converter Applications

- Small footprint due to a small and thin package
- High-speed switching
- Small gate charge: QSW = 3.7 nC (typ.)
- Low drain-source ON-resistance: $RDS(ON) = 0.38\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 3.9S$ (typ.)
- Low leakage current: $I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 200 \text{V)}$
- Enhancement mode: $V_{th} = 2.0 \text{ to } 4.0 \text{ V (VDS} = 10 \text{ V, ID} = 1 \text{ mA)}$

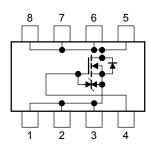
Absolute Maximum Ratings (Ta = 25°C)

Characte	eristic	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	200	V	
Drain-gate voltage (R	$R_{GS} = 20 \text{ k}\Omega$	V_{DGR}	200	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	ID	5.5	А	
Drain current	Pulsed (Note 1)	I_{DP}	11		
Drain power dissipation	on (Tc=25°C)	P_{D}	45	W	
Drain power dissipation	on (t = 10 s) (Note 2a)	P_{D}	2.8	W	
Drain power dissipation	on (t = 10 s) (Note 2b)	P _D	1.6	W	
Single-pulse avalanch	he energy (Note 3)	E _{AS}	19	mJ	
Avalanche current		I _{AR}	5.5	Α	
Repetitive avalanche	energy 「c=25°C) (Note 4)	E _{AR}	1.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature	range	T _{stg}	-55 to 150	°C	



Weight: 0.069 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high

temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

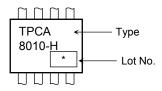
This transistor is an electrostatic-sensitive device. Handle with care.



Thermal Characteristics

Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case (Tc=25°C)	R _{th (ch-c)}	2.78	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R _{th (ch-a)}	44.6	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R _{th (ch-a)}	78.1	°C/W

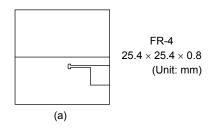
Marking (Note 5)

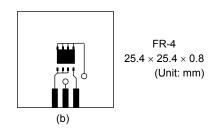


Note 1: The channel temperature should not exceed 150°C during use.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)

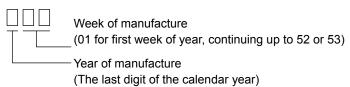




Note 3: $V_{DD} = 50$ V, $T_{ch} = 25^{\circ}C$ (initial), L = 1mH, $R_G = 25~\Omega$, $I_{AR} = 5.5~A$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: * Weekly code: (Three digits)



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TPCA8010-H



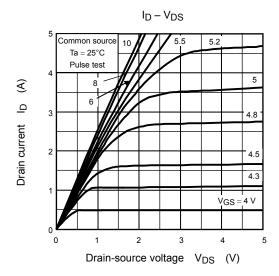
Electrical Characteristics (Ta = 25°C)

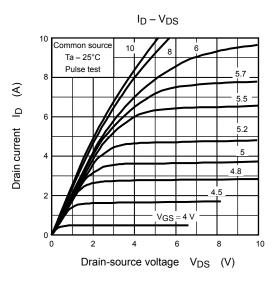
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Drain cutoff curre	nt	I _{DSS}	V _{DS} = 200 V, V _{GS} = 0 V	_	_	100	μА
		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	200	_	_	
Drain-source brea	akdown voltage	V (77) 70V	$I_D = 10 \text{ mA}, V_{GS} = -5 \text{ V}$	200	_	_	V
		V _(BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	150	_	_	
Gate threshold vo	oltage	V _{th}	$V_{DS} = 10 \text{ V}, I_{D} = 1 \text{ mA}$	2.0	_	4.0	V
Drain-source ON-resistance		R _{DS} (ON)	$V_{GS} = 10 \text{ V}, I_D = 2.7 \text{ A}$	_	0.38	0.45	Ω
Forward transfer admittance		Y _{fs}	$V_{DS} = 10 \text{ V}, I_D = 2.7 \text{ A}$	1.8	3.9	_	S
Input capacitance		C _{iss}		_	600	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	20	_	
Output capacitance		C _{oss}		_	220	_	
Switching time	Rise time	t _r	V _{GS} 10 V	_	7	_	ns
	Turn-ON time	t _{on}		_	17	_	
	Fall time	t _f		_	13	_	
	Turn-OFF time	t _{off}	Duty ≦ 1%, t _w = 10 μs	_	70	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 160 \text{ V}, V_{GS} = 10 \text{ V},$ $I_D = 5.5 \text{ A}$	_	10	_	nC
Gate-source charge		Q _{gs}			7.6		
Gate-drain ("miller") charge		Q _{gd}		_	2.4	_	
Gate switch charge		Q _{sw}		_	3.7	_	

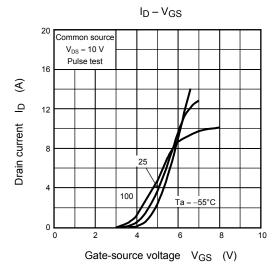
Source-Drain Ratings and Characteristics (Ta = 25°C)

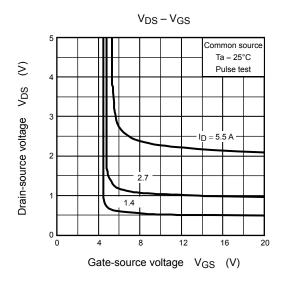
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	I _{DRP}	_	_	_	11	Α
Forward voltage (diode)			V _{DSF}	I _{DR} = 5.5 A, V _{GS} = 0 V	_	_	-2.0	V

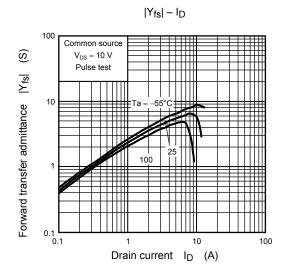
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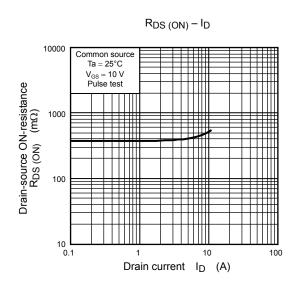


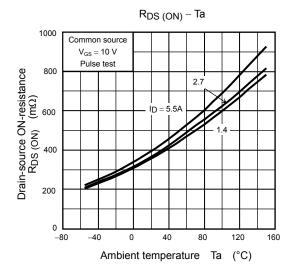


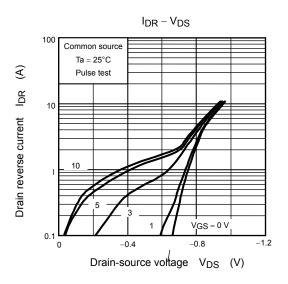


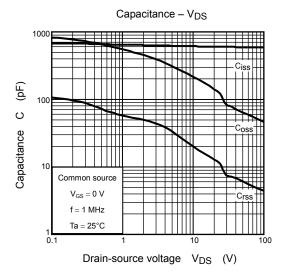


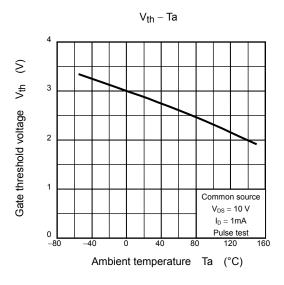


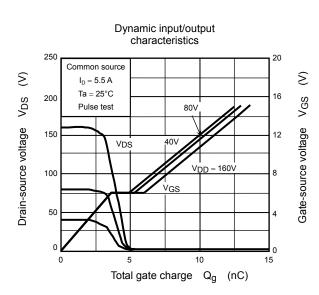




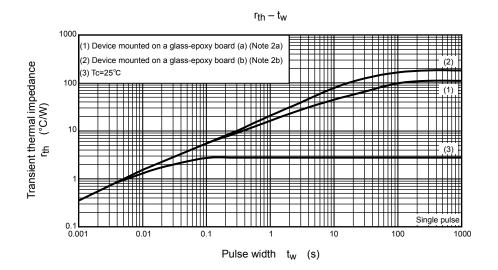


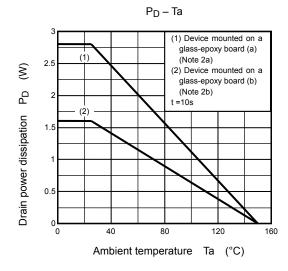


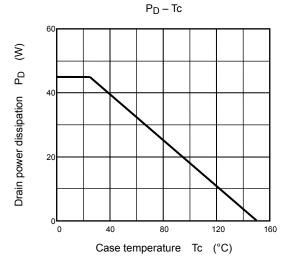


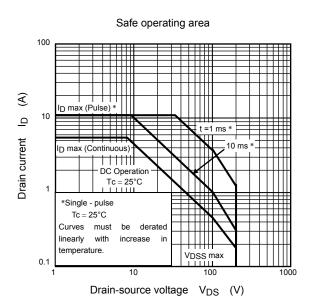


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